

# Series - Electronic and optical semiconductor devices

①

## Series 6 - Semiconductor statistics and Hall effect in compensated semiconductors

### Exercise 1 - Degenerate bulk semiconductor - Sommerfeld expansion

$$1. N_c = 2 \left( \frac{2\pi m_e^* k_B T}{h^2} \right)^{3/2}$$

$$\text{Si, } m_e^* = 0.916 m_0$$

$$\text{GaAs, } m_e^* = 0.067 m_0$$

$$N_c(\text{Si}) = 2 \left[ \frac{2\pi \times 0.916 \times 9.1 \times 10^{-31} \times 1.38 \times 10^{-23} \times 300}{(6.64 \times 10^{-34})^2} \right]^{3/2} \sim 2.18 \times 10^{25} \text{ m}^{-3}$$

i.e.  $2.18 \times 10^{19} \text{ cm}^{-3}$

$$N_c(\text{GaAs}) \sim 4.31 \times 10^{17} \text{ cm}^{-3}$$

2 - We consider (1.4) limited to its first two terms.

$$\int_{-\infty}^{+\infty} p_c(E) f_{-1}(E) dE \approx \int_{-\infty}^{\mu} p_c(E) dE + \frac{\pi^2}{6} (k_B T)^2 p_c'(\mu)$$

Knowing that  $p_c(E) = 0$  for energies  $E < E_c$ , we get the following relationship:

$$n = \int_{E_c}^{\mu} p_c(E) dE + \frac{\pi^2}{6} (k_B T)^2 p_c'(\mu)$$

$$\text{i.e. } n = \frac{1}{2\pi^2} \left( \frac{2m_e^*}{\hbar^2} \right)^{3/2} \underbrace{\int_{E_c}^{\mu} (E - E_c)^{1/2} dE}_I + \frac{\pi^2}{6} (k_B T)^2 \left. \frac{dp_c(E)}{dE} \right|_{E=\mu}$$

$$I = \left[ \frac{2}{3} (E - E_c)^{3/2} \right]_{E_c}^{\mu} = \frac{2}{3} (\mu - E_c)^{3/2}$$

$$\left. \frac{dp_c(E)}{dE} \right|_{E=\mu} = \frac{1}{2\pi^2} \left( \frac{2m_e^*}{\hbar^2} \right)^{3/2} \times \frac{1}{2} (\mu - E_c)^{-1/2}$$

$$\text{So that } n = \frac{1}{3\pi^2} \left( \frac{2m_e^*}{\hbar^2} \right)^{3/2} (\mu - E_c)^{3/2} + \frac{1}{24} (k_B T)^2 \left( \frac{2m_e^*}{\hbar^2} \right)^{3/2} (\mu - E_c)^{-1/2}$$

Since  $N_c = 2 \left( \frac{2\pi m_e^* k_B T}{h^2} \right)^{3/2}$ , we obtain after some simplifications:

$$n = \frac{4}{3\pi^2} N_c \left( \frac{\mu - E_c}{k_B T} \right)^{3/2} \left[ 1 + \frac{\pi^2}{8} \left( \frac{k_B T}{\mu - E_c} \right)^2 \right] \quad (1.5) \quad \text{with } A = \frac{4}{3\pi^2} \text{ and } B = \frac{\pi^2}{8}$$

3. As  $N_c \propto (k_B T)^{3/2}$  and in the highly degenerate case  $\mu - E_c \gg k_B T$ ,  
the free carrier density will reduce to

$$n \approx \frac{8}{3\pi^2} \left( \frac{2m^*}{\hbar^2} \right)^{3/2} (\mu - E_c)^{3/2} = \frac{1}{3\pi^2} \left( \frac{2m^*}{\hbar^2} \right)^{3/2} (\mu - E_c)^{3/2}$$

It is thus seen that the free carrier density becomes independent of the temperature, i.e. the semiconductor exhibits a transition toward a metallic behavior. However we should not speak of a metal here since the involved densities are not comparable. Indeed, if  $\mu - E_c \approx 5k_B T$  (at  $T = 300\text{K}$ ) then  $n \approx 1.74 \times 10^{20} \text{cm}^{-3}$  in the case of silicon which is at least two orders of magnitude lower than in a metal (in a few  $10^{22} \text{cm}^{-3}$ ).

4. See graph

Additional information on the effective density of states

$$n = \int_{-\infty}^{+\infty} p_c(E) f_n(E) dE$$

$$\text{3D case } n = \frac{1}{2\pi^2} \left( \frac{2m^*}{\hbar^2} \right)^{3/2} \int_{E_c}^{+\infty} (E - E_c)^{1/2} \times \frac{1}{1 + \exp\left(\frac{E - E_F}{k_B T}\right)} dE$$

Boltzmann approximation  $\rightarrow f_n(E) \sim \exp\left[-\frac{(E - E_F)}{k_B T}\right]$

$\hookrightarrow$  valid when the Fermi level lies deeply enough in the band gap so that

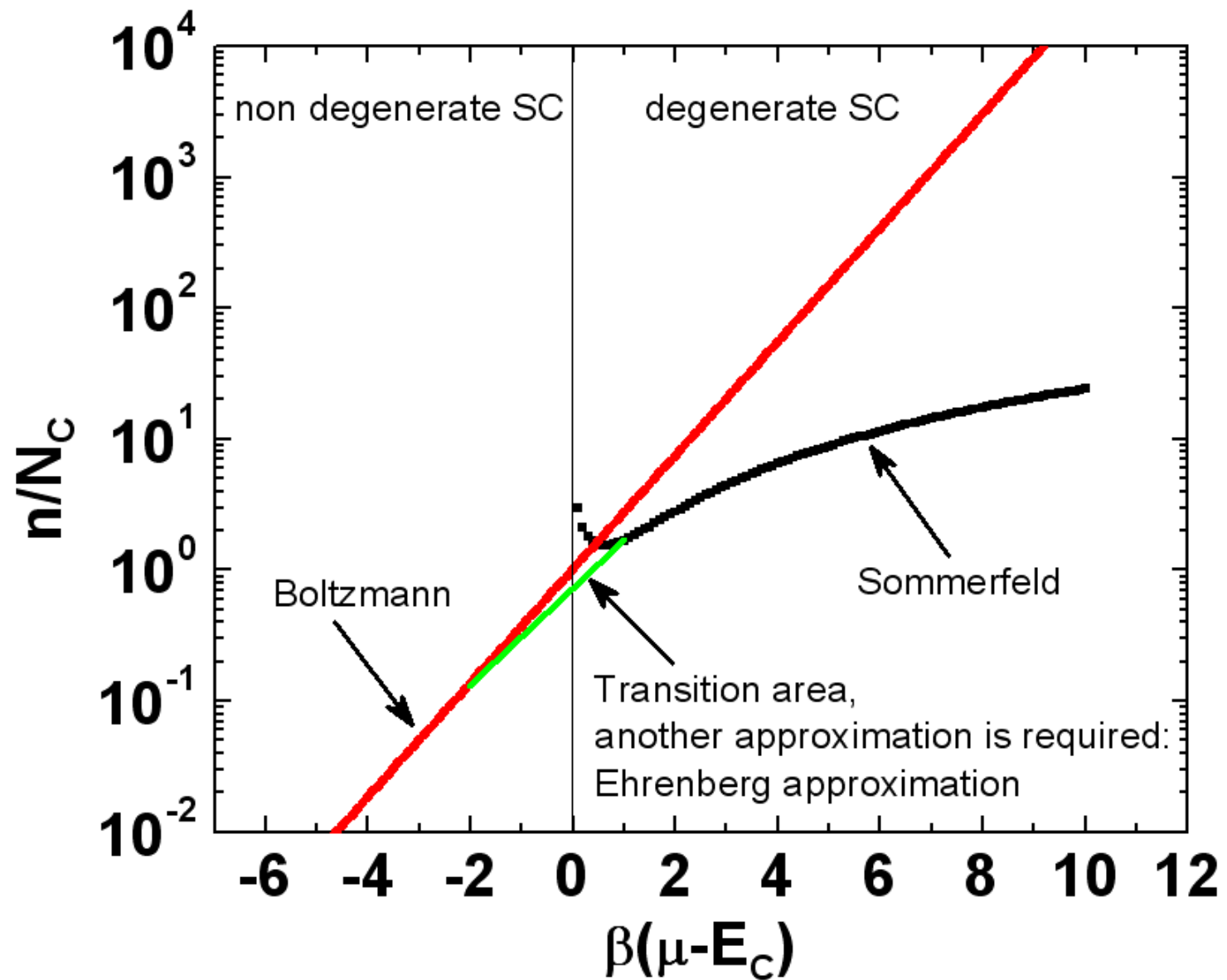
$$(E - E_F) \gg k_B T$$

$$n = \int_{E_c}^{+\infty} p_c(E) \exp\left[-(E - E_F)/k_B T\right] dE$$

$$n = \frac{1}{2\pi^2} \left( \frac{2m^*}{\hbar^2} \right)^{3/2} \int_{E_c}^{+\infty} (E - E_c)^{1/2} \exp\left[-(E - E_F)/k_B T\right] dE$$

$$\text{i.e. } n = \frac{1}{2\pi^2} \left( \frac{2m^*}{\hbar^2} \right)^{3/2} \exp\left[-(E_c - E_F)/k_B T\right] \underbrace{\int_{E_c}^{+\infty} (E - E_c)^{1/2} \exp\left[-(E - E_c)/k_B T\right] dE}_{I'}$$

I'



## Evaluation of $I'$

$$I' = \int_{E_c}^{+\infty} (E - E_c)^{1/2} \exp[-\beta(E - E_c)] dE \quad \text{and } \beta = \frac{1}{k_B T}$$

Change of variable #1,  $x = E - E_c$

$$\Rightarrow I' = \int_0^{+\infty} x^{1/2} \exp(-\beta x) dx$$

Change of variable #2,  $x^{1/2} = X$

$$dx = \frac{1}{2} x^{-1/2} dx \Rightarrow dx = 2x^{1/2} dX = 2X dX$$

$$I' = \int_0^{+\infty} 2X^2 \exp(-\beta X^2) dX$$

Note that integral of the form  $I_n = \int_0^{+\infty} x^n e^{-ax^2} dx$  are related through the formulas  $I_{n+2} = \frac{n+1}{2a} I_n$  ( $n \in \mathbb{N}$ ) and  $I_0 = \frac{1}{2} \sqrt{\frac{\pi}{a}}$ ,  $I_1 = \frac{1}{2a}$

As a consequence  $I' = 2I_2 = 2 \times \frac{1}{2\beta} I_0$  so that  $I' = \frac{\beta^{-3/2} \sqrt{\pi}}{2}$

which leads to  $N_c = \frac{1}{2\pi^2} \left( \frac{2m_e^*}{\hbar^2} \right)^{3/2} \times \frac{(k_B T)^{3/2}}{2} \sqrt{\pi}$

$$\Rightarrow N_c = 2 \left( \frac{2\pi m_e^* k_B T}{\hbar^2} \right)^{3/2} \quad \text{and} \quad n = N_c \exp\left[-\frac{(E_c - E_F)}{k_B T}\right]$$

This last expression is valid as long as  $E_F$  is far from  $E_c \Rightarrow E_c - E_F > k_B T$  (cf. Question 4 - exercise 1).

The denomination "effective density of states" means that the occupied bands behave like two discrete levels with a concentration  $N_c$  and  $N_v$  in the semiconductor with respect to the Fermi level (approximation valid for slightly doped semiconductors only). However, one should not identify these two quantities ( $N_c$  and  $N_v$ ) to the total number of states available in each band. It is a prefactor with a characteristic value allowing estimating beyond which doping level a semiconductor will be degenerate.

## Exercise 1 - Maxwell-Boltzmann velocity distribution function

1. The most probable velocity for electrons corresponds to the maximum of the velocity distribution function  $F(v)$ , i.e.  $v_{thmax}$  is such that  $\frac{dF(v)}{dv} = 0$ .

$$\text{Therefore we have } \frac{d}{dv} \left( v^2 e^{-m^* v^2 / 2 k_B T} \right) = 0$$

$$\text{i.e. } 2v e^{-m^* v^2 / 2 k_B T} - \frac{m^* v^3}{k_B T} e^{-m^* v^2 / 2 k_B T} = 0$$

$$\text{which leads to } 2v \left( 1 - \frac{m^* v^2}{2 k_B T} \right) = 0$$

As  $v$  is necessarily different from zero, we obtain

$$v_{thmax} = \left( \frac{2 k_B T}{m^*} \right)^{1/2}$$

2. The root mean square velocity is linked to the mean thermal energy through the relation  $\frac{1}{2} m^* v_{rms}^2 = \frac{3}{2} k_B T$ , where the mean thermal energy is equal to  $\frac{k_B T}{2}$  per degree of freedom so that we get

$$v_{rms} = \left( \frac{3 k_B T}{m^*} \right)^{1/2}$$

Alternatively, the mathematical approach is:

$$v_{rms}^2 = \frac{\int_0^{+\infty} v^2 F(v) dv}{\int_0^{+\infty} F(v) dv}$$

$= 1$  as  $F(v)$  is a normalized distribution function.

$$\text{i.e. } v_{rms}^2 = 4\pi \left( \frac{m^*}{2\pi k_B T} \right)^{3/2} \int_0^{+\infty} v^4 e^{-m^* v^2 / 2 k_B T} dv$$

Knowing that integrals of the form  $I_n = \int_0^{+\infty} x^n e^{-ax^2} dx$  are related through the formulas  $I_{n+2} = \frac{n+1}{2a} I_n$  ( $n \in \mathbb{N}$ ) where  $I_0 = \frac{1}{2} \sqrt{\frac{\pi}{a}}$  and  $I_1 = \frac{1}{2a}$

we thus obtain  $I_4 = \frac{3}{8a^2} \sqrt{\frac{\pi}{a}}$  where in our case  $a = \frac{m^*}{2k_B T}$  so that

$$I_4 = \frac{3\sqrt{\pi}}{8} \left( \frac{2k_B T}{m^*} \right)^{5/2} \text{ which leads to } v_{rms}^2 = 4\pi \times \frac{3\sqrt{\pi}}{8} \left( \frac{m^*}{2\pi k_B T} \right)^{3/2} \cdot \left( \frac{2k_B T}{m^*} \right)^{5/2}$$

$$\text{i.e. } v_{rms}^2 = \frac{3}{2} \pi^{3/2} \cdot \pi^{-3/2} \left( \frac{m^*}{2k_B T} \right)^{3/2} \cdot \left( \frac{2k_B T}{m^*} \right)^{5/2} \Rightarrow$$

$$v_{rms} = \left( \frac{3k_B T}{m^*} \right)^{1/2}$$

3. The mean velocity is given by: 
$$\bar{v}_{th} = \frac{\int_0^{+\infty} v F(v) dv}{\int_0^{+\infty} F(v) dv}$$

which leads to 
$$\bar{v}_{th} = 4\pi \left( \frac{m^*}{2\pi k_B T} \right)^{3/2} \underbrace{\int_0^{+\infty} v^3 e^{-m^* v^2 / 2k_B T} dv}_{I_3}$$

$$I_3 = \frac{1}{a} I_1 = \frac{1}{2a^2}$$
 with  $a = \frac{m^*}{2k_B T}$

then 
$$I_3 = \frac{1}{2} \times 4 \left( \frac{k_B T}{m^*} \right)^2$$
 so that we get 
$$\bar{v}_{th} = 8\pi \left( \frac{m^*}{2\pi k_B T} \right)^{3/2} \left( \frac{k_B T}{m^*} \right)^2$$

i.e. 
$$\bar{v}_{th} = \left( \frac{8 k_B T}{\pi m^*} \right)^{1/2}$$

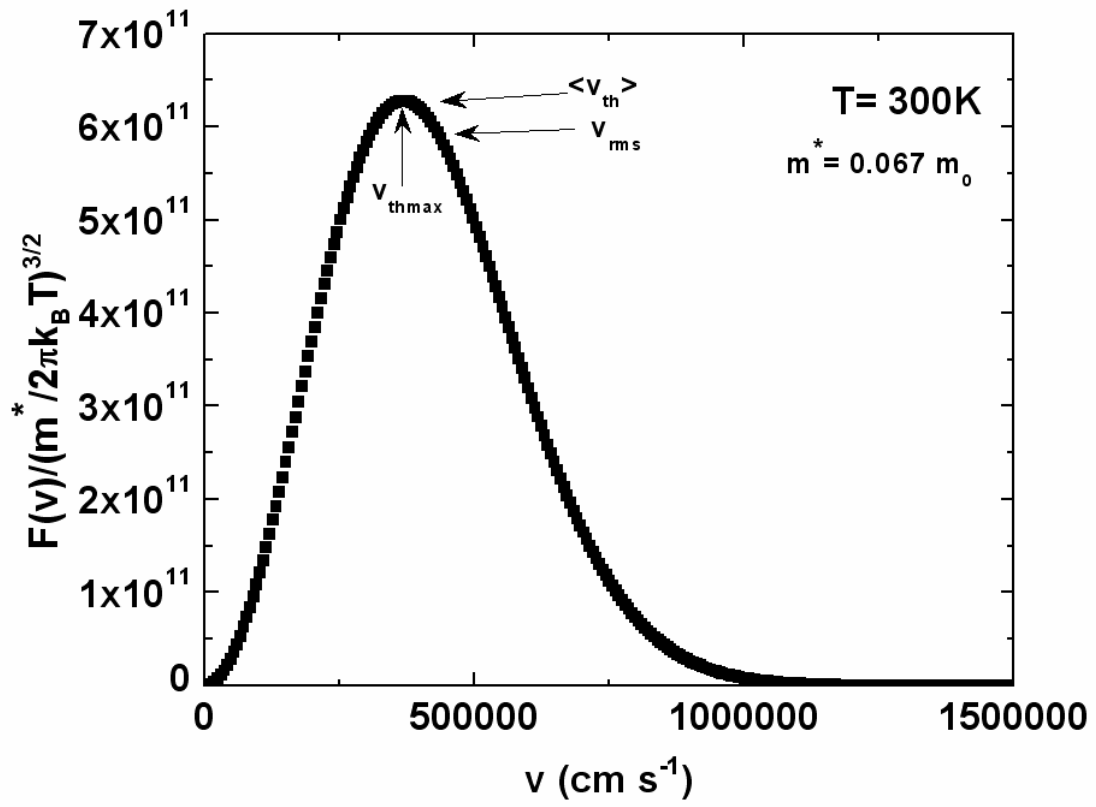
Finally, we thus have  $v_{rms} > \bar{v}_{th} > v_{th,max}$   
 (cf. figure showing the velocity distribution function of electrons in GaAs at  $T = 300K$ )

4.  $|\vec{E}| = 1 \times 10^5 \text{ V.cm}^{-1}$

$|\vec{v}_d(Si)| = 1.35 \times 10^8 \text{ cm.s}^{-1}$  and  $|\vec{v}_d(GaAs)| = 8 \times 10^8 \text{ cm.s}^{-1}$

$v_{rms}(Si) \approx 1.22 \times 10^7 \text{ cm.s}^{-1}$  and  $v_{rms}(GaAs) \approx 4.51 \times 10^7 \text{ cm.s}^{-1}$

It is seen that in this specific case the drift velocity  $|\vec{v}_d|$  exceeds  $v_{rms}$  by more than one order of magnitude. Obviously such a situation is clearly a physical nonsense as for high fields, electrons reach their saturation velocity, the excess energy being released to the atomic lattice through the emission of optical phonons (cf. lecture).



### Exercise 3 - Generalization of the statistics of donor levels

1. First, we can establish the relationship giving the number density of electrons  $n_d$  bound to donor sites:  $n_d = N_d \langle n \rangle$  where  $\langle n \rangle$  corresponds to the mean number of electrons in the levels at thermal equilibrium.

The donor level can be occupied in the following way:

(a) empty level,  $N_j = 0$ ,  $E_j = 0$ ,  $g_j^{-1} = 1$   $\rightarrow$  1 configuration is associated with this level!

(b) singly occupied level,  $N_j = 1$ ,  $E_j = E_d$ ,  $g_j^{-1} = 2$  because the donor level can be occupied by an  $e^-$  of spin  $\uparrow$  or  $\downarrow$

(c) doubly occupied level,  $N_j = 2$ ,  $E_j = 2E_d + \Delta$ ,  $g_j^{-1} = 1$

$$\text{As a result we get: } \langle n \rangle = \frac{2e^{-\beta(E_d - \mu)} + 2e^{-\beta(2E_d + \Delta - 2\mu)}}{1 + 2e^{-\beta(E_d - \mu)} + e^{-\beta(2E_d + \Delta - 2\mu)}}$$

$$\text{i.e. } \langle n \rangle = \frac{2e^{-\beta(E_d - \mu)}}{2e^{-\beta(E_d - \mu)}} \frac{1 + e^{-\beta(E_d + \Delta - \mu)}}{\frac{1}{2}e^{\beta(E_d - \mu)} + 1 + \frac{1}{2}e^{-\beta(E_d + \Delta - \mu)}}$$

and finally

$$n_d = \frac{N_d (1 + e^{-\beta(E_d + \Delta - \mu)})}{\frac{1}{2}e^{\beta(E_d - \mu)} + 1 + \frac{1}{2}e^{-\beta(E_d + \Delta - \mu)}} \quad (4.2)$$

2. As  $\Delta \rightarrow +\infty$ ,  $e^{-\beta(E_d + \Delta - \mu)} \rightarrow 0$  so that eq. (4.2) is reduced to

$$n_d = \frac{N_d}{\frac{1}{2}e^{\beta(E_d - \mu)} + 1} \quad (4.3)$$

3. As  $\Delta \rightarrow 0$ , (4.2) can be simplified in the following way:

$$n_d = \frac{1 + e^{-\beta(E_d - \mu)}}{\frac{1}{2}e^{\beta(E_d - \mu)} + 1 + \frac{1}{2}e^{-\beta(E_d - \mu)}} N_d$$

By putting  $x = \beta(E_D - \mu)$ , we get  $n_D = 2N_D \frac{1 + e^{-x}}{2 + e^x + e^{-x}}$

As  $e^x + e^{-x} + 2 = (e^x + 1)(e^{-x} + 1)$ , we then obtain

$$n_D = 2 \frac{(1 + e^{-x})}{(1 + e^x)} \times \frac{1}{1 + e^x} N_D$$

i.e.  $n_D = 2N_D \underbrace{[1 + e^{\beta(E_D - \mu)}]^{-1}}_{\text{Fermi-Dirac distribution}}$

and finally

$$n_D = 2N_D f_{FD}(E_D)$$

factor indicating that the donor levels can be occupied by  $2e^-$  of opposite spin.

4- We still have the relationship  $n_D = N_D \langle n \rangle$ . However, each donor level will introduce many bound electronic orbitals of energy  $E_i$ . As a consequence in (4.3)  $E_D$  must be replaced with the  $E_i$ . If we consider a system where donor levels possess two orbitals, we get from (4.3) (in fact from (4.1))

$$n_D = N_D \left[ \frac{2e^{-\beta(E_1 - \mu)} + 2e^{-\beta(E_2 - \mu)}}{1 + 2e^{-\beta(E_1 - \mu)} + 2e^{-\beta(E_2 - \mu)}} \right]$$

$$\text{i.e. } n_D = 2N_D \frac{\sum_{i=1}^2 e^{-\beta(E_i - \mu)}}{2 \sum_{i=1}^2 e^{-\beta(E_i - \mu)}} \times \frac{1}{\frac{1}{2} \left( \sum_{i=1}^2 e^{-\beta(E_i - \mu)} \right)^{-1} + 1}$$

$$\text{and finally } n_D = N_D \frac{1}{\frac{1}{2} \left( \sum_{i=1}^2 e^{-\beta(E_i - \mu)} \right)^{-1} + 1}$$

Such an equation can be extended to a larger number of orbitals which finally leads to (4.4).